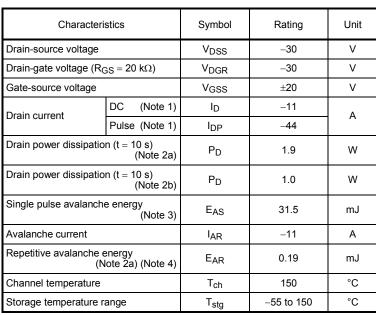
## TOSHIBA

TOSHIBA Field Effect Transistor Silicon P Channel MOS Type (U-MOS IV)

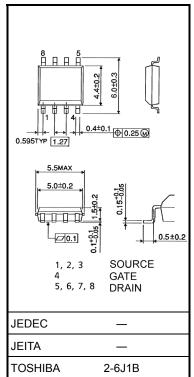
# **TPC8113**

Lithium Ion Battery Applications Notebook PC Applications Portable Equipment Applications

- Small footprint due to small and thin package
- Low drain-source ON resistance:  $R_{DS}$  (ON) = 8 m $\Omega$  (typ.)
- High forward transfer admittance:  $|Y_{fs}| = 23 \text{ S} (typ.)$
- Low leakage current:  $I_{DSS} = -10 \ \mu A \ (max) \ (V_{DS} = -30 \ V)$
- Enhancement-mode:  $V_{th}$  = -0.8 to -2.0 V ( $V_{DS}$  = -10 V,  $I_D$  = -1 mA)

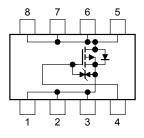


#### Absolute Maximum Ratings (Ta = 25°C)



Weight: 0.080 g (typ.)

#### **Circuit Configuration**



Note: (Note 1), (Note 2), (Note 3) and (Note 4): See the next page.

Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings. Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/Derating Concept and Methods) and individual reliability data (i.e. reliability test report and estimated failure rate, etc.).

This transistor is an electrostatic-sensitive device. Please handle with caution.

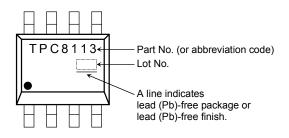
Unit: mm

# TOSHIBA

#### **Thermal Characteristics**

Characteristics	Symbol	Max	Unit	
Thermal resistance, channel to ambient (t = 10 s) (Note 2a)	R <sub>th (ch-a)</sub>	65.8	°C/W	
Thermal resistance, channel to ambient (t = 10 s) (Note 2b)	R <sub>th (ch-a)</sub>	125	°C/W	

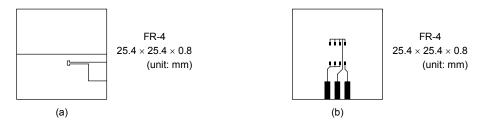
#### Marking (Note 5)



Note 1: Ensure that the channel temperature does not exceed 150°C.

Note 2:

(a) Device mounted on a glass-epoxy board (a) (b) Device mounted on a glass-epoxy board (b)



- Note 3:  $V_{DD} = -24$  V,  $T_{ch} = 25^{\circ}C$  (initial), L = 0.2 mH,  $R_G = 25 \Omega$ ,  $I_{AR} = -11$  A
- Note 4: Repetitive rating: pulse width limited by maximum channel temperature
- Note 5: on lower left of the marking indicates Pin 1.

\* Weekly code: (Three digits)



Week of manufacture (01 for the first week of a year: sequential number up to 52 or 53)

 Year of manufacture (The last digit of a year)

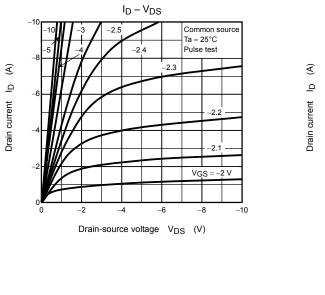
## Electrical Characteristics (Ta = 25°C)

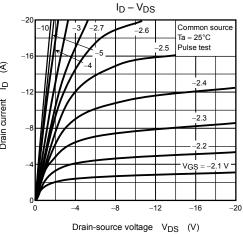
Characteristics		Symbol	Test Condition	Min	Тур.	Max	Unit
Gate leakage current		I <sub>GSS</sub>	$V_{GS}=\pm 16~V,~V_{DS}=0~V$	_		±10	μA
Drain cut-OFF current		I <sub>DSS</sub>	$V_{DS} = -30 \text{ V}, \text{ V}_{GS} = 0 \text{ V}$			-10	μA
Drain-source breakdown voltage		V (BR) DSS	$I_D = -10 \text{ mA}, V_{GS} = 0 \text{ V}$	-30			v
		V (BR) DSX	$I_D = -10$ mA, $V_{GS} = 20$ V	-15	_	_	
Gate threshold voltage		V <sub>th</sub>	$V_{DS} = -10 \text{ V}, \text{ I}_{D} = -1 \text{ mA}$	-0.8		-2.0	V
Drain-source ON resistance		Dealer	$V_{GS}=-4~V,~I_D=-5.5~A$	_	12	18	mΩ
		R <sub>DS</sub> (ON)	$V_{GS} = -10 \text{ V}, \text{ I}_{D} = -5.5 \text{ A}$	_	8	10	
Forward transfer admittance		Y <sub>fs</sub>	$V_{DS} = -10 \text{ V}, \text{ I}_{D} = -5.5 \text{ A}$	11	23	_	S
Input capacitance		C <sub>iss</sub>		_	4500	_	pF
Reverse transfer capacitance		C <sub>rss</sub>	$V_{DS} = -10 \text{ V}, \text{ V}_{GS} = 0 \text{ V}, \text{ f} = 1 \text{ MHz}$	_	540	_	
Output capacitance		C <sub>oss</sub>		_	650	_	
Switching time	Rise time	tr	$V_{GS} \xrightarrow{0}_{-10} V \xrightarrow{I_D} \xrightarrow{I_D} \xrightarrow{-5.5 \text{ A}}_{Ci} \xrightarrow{O}_{i} \xrightarrow{V_{OUT}}_{Ci} \xrightarrow{I_D} \xrightarrow{O}_{i} \xrightarrow{O}_{i} \xrightarrow{V_{OUT}}_{Ci}$	_	6	_	- ns
	Turn-ON time	t <sub>on</sub>			13	_	
	Fall time	t <sub>f</sub>	RL=2	_	120		
	Turn-OFF time	t <sub>off</sub>	$V_{DD}\simeq -15~V \label{eq:DD}$ Duty $\leq$ 1%, $t_{W}=$ 10 $\mu s$		340		
Total gate charge (gate-source plus gate-drain)		Qg	$V_{DD} \simeq -24 \text{ V}, \text{ V}_{GS} = -10 \text{ V},$		107	_	nC
Gate-source charge 1		Q <sub>gs1</sub>	$I_{\rm D} = -11  {\rm A}$		12		
Gate-drain ("miller") charge		Q <sub>gd</sub>	]	_	20	_	

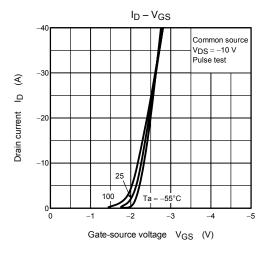
### Source-Drain Ratings and Characteristics ( $Ta = 25^{\circ}C$ )

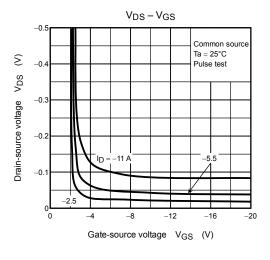
Characteristics		Symbol	Test Condition	Min	Тур.	Max	Unit	
Drain reverse current	Pulse	(Note 1)	IDRP	—	_	_	-44	А
Forward voltage (diode	)		V <sub>DSF</sub>	$I_{DR} = -11 \text{ A}, V_{GS} = 0 \text{ V}$			1.2	V

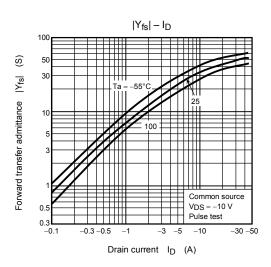
## **TOSHIBA**

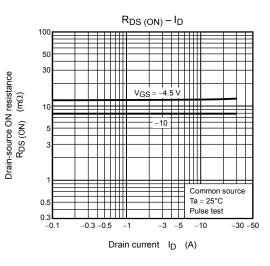


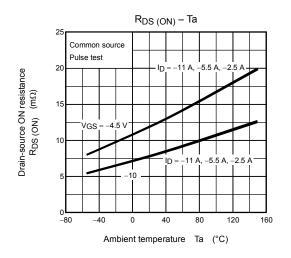


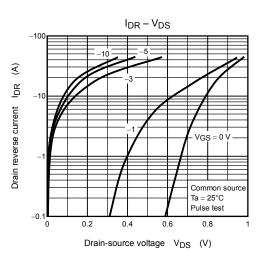


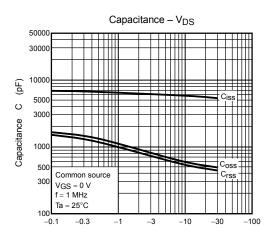




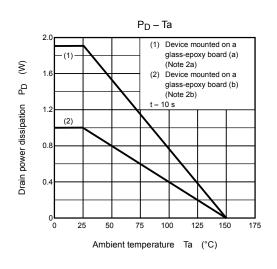


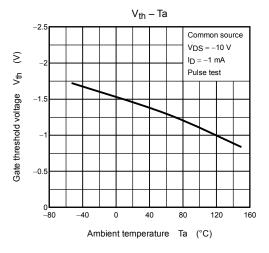


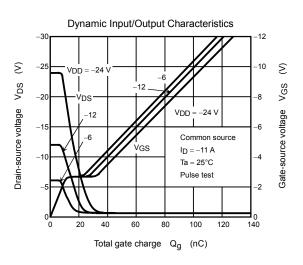


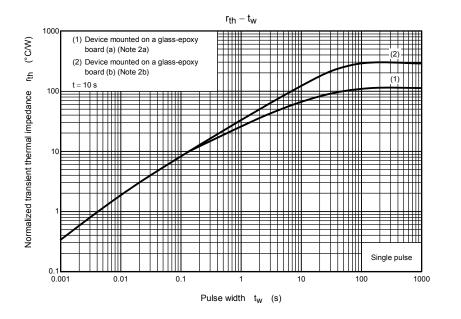












Safe Operating Area 100 ID max (pulse)\* ++++++ +++++ ms ПП 10 ms\* 10 € +++++ Drain current I<sub>D</sub> +++++ 0.1 \*: Single pulse Ta = 25°C Curves must be derated linearly with increase in VDSS max temperature 0.01 0.01 0.1 1 10 100 Drain-source voltage V<sub>DS</sub> (V)

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